

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/630,948	<b>Applicant(s)/Patent under Reexamination</b> HANG, WEI ZHAN
<b>Examiner</b> Phi D. A	<b>Art Unit</b> 3637	

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>